



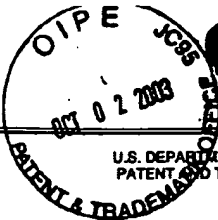
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Technology Center 2600 SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 202594US2RD		SERIAL NO. 09/772,894	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Junichi AKIYAMA, et al.			
				FILING DATE January 31, 2001		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	2-037501	02/07/90	JAPAN (with English Abstract)			X
	AP						
	AQ						
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	AS						
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	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	H. KATAYAMA, et al., J. Magn. Soc. Jpn., Vol. 32, No. 8, pps. 1901-1906, "LASER-ASSISTED MAGNETIC RECORDING TECHNOLOGIES," 1999					
	AX	H. KATAYAMA, et al., Proceedings of Magneto-Optical Recording International Symposium '99, J. Magn. Soc. Jpn., Vol. 23, No. S1, pps. 233-236, "NEW MAGNETIC RECORDING METHOD USING LASER ASSISTED READ/WRITE TECHNOLOGIES," 1999					
	AY	H. SAGA, et al., Proceedings of Magneto-Optical Recording International Symposium '99, J. Magn. Soc. Jpn., Vol. 23, No. S1, pps. 225-228, "A NEW PERPENDICULAR MAGNETIC RECORDING METHOD WITH A MAGNETIC -OPTICAL COMMON PREFORMAT," 1999					
	AZ						
Examiner <i>P. J. S.</i>					Date Considered <i>9/30/02</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Junichi AKIYAMA, et al.			
				FILING DATE January 31, 2001		GROUP 2653	
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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S	AO	08-222814	08/30/96	Japan (w/English Abstract)			x
	AP	02-189751	07/25/90	Japan (w/English Abstract)			x
	AQ	06-203303	07/22/94	Japan (w/English Abstract)			x
	AR	06-243527	09/02/94	Japan (w/English Abstract)			x
	AS	11-265520	09/28/99	Japan (w/English Abstract)			x
	AT	11-096608	04/09/99	Japan (w/English Abstract)			x
	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>TS/DS</i>					Date Considered 11/13/23		
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PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

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SERIAL NO.

09/772,894

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Junichi AKIYAMA, et al.

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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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## FOREIGN PATENT DOCUMENTS

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	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	Gen-ichi HATAKOSHI and Hideto FURUYAMA, "Polarization Dependence Analysis of Optical Loss in Small-Aperture Metal Waveguides for Near-Field Optics," Jpn. J. Appl. Phys. Vol. 40 (2001), pp. 1548-1551 <i>in complete date</i>
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attachedExaminer *SPD*

Date Considered

*5/10/04*

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